Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/084,442	CHEN ET AL.	
Examiner	Art Unit	_
N. Bhat	1764	

	SEARCHED				
Class	Subclass	Date	Examiner		
422	194	3/31/2005	NB		
422	177	3/31/2005	NB		
422	182	3/31/2005	NB		
422	222	3/31/2005	NB		
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TAI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST	3/31/200	5 NB		
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